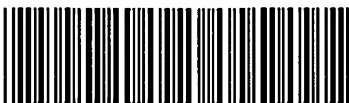


Search Notes

Application/Control No.

10/693,209

Examiner

Phu Vu

Applicant(s)/Patent under
Reexamination

CHANG ET AL.

Art Unit

2871

SEARCHED

Class	Subclass	Date	Examiner
349	106-109	4/17/2005	P.V.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
text search EAST (US Pat, PGR) (See printout)	9/	